PBSS4260PAN 60 V, 2 A NPN/NPN low VCEsat (BISS) transistor 12 December 2012 Pro

**Product data sheet** 

## 1. General description

NPN/NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor in a leadless medium power DFN2020-6 (SOT1118) Surface-Mounted Device (SMD) plastic package.

NPN/PNP complement: PBSS4260PANP. PNP/PNP complement: PBSS5260PAP.

## 2. Features and benefits

- Very low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability  $I_C$  and  $I_{CM}$
- High collector current gain h<sub>FE</sub> at high I<sub>C</sub>
- Reduced Printed-Circuit Board (PCB) requirements
- High efficiency due to less heat generation
- AEC-Q101 qualified

## 3. Applications

- Load switch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

## 4. Quick reference data

Table 1. Quie	ck reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transistor							
V <sub>CEO</sub>	collector-emitter voltage	open base		-	-	60	V
I <sub>C</sub>	collector current			-	-	2	А
I <sub>CM</sub>	peak collector current	single pulse; t <sub>p</sub> ≤ 1 ms		-	-	3	А
Per transistor							
R <sub>CEsat</sub>	collector-emitter saturation resistance	$\begin{split} \textbf{I}_{C} &= 1 \text{ A}; \text{ I}_{B} = 100 \text{ mA}; \text{ pulsed}; \\ \textbf{t}_{p} &\leq 300  \mu\text{s};  \delta \leq 0.02 ;  \textbf{T}_{amb} = 25 ^{\circ}\text{C} \end{split}$		-	-	165	mΩ





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# 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	E1	emitter TR1	6 5 4	C1 B2 E2
2	B1	base TR1		
3	C2	collector TR2	7 8	
4	E2	emitter TR2		
5	B2	base TR2	1 2 3	E1 B1 C2
6	C1	collector TR1	Transparent top view sym1 DFN2020-6 (SOT1118)	sym140
7	C1	collector TR1	21112020 0 (0011110)	
8	C2	collector TR2		

# 6. Ordering information

Table 3. Ordering in	formation		
Type number Package			
	Name	Description	Version
PBSS4260PAN	DFN2020-6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals; body $2 \times 2 \times 0.65$ mm	SOT1118

## 7. Marking

Table 4. Marking codes	
Type number	Marking code
PBSS4260PAN	2N

# 8. Limiting values

### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per transist	tor				
V <sub>CBO</sub>	collector-base voltage	open emitter	-	60	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	60	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	7	V
I <sub>C</sub>	collector current		-	2	А
I <sub>CM</sub>	peak collector current	single pulse; t <sub>p</sub> ≤ 1 ms	-	3	А
I <sub>B</sub>	base current		-	0.3	А
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Product data sheet

12 December 2012

# PBSS4260PAN

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Symbol	Parameter	Conditions	M	lin Max	Unit
I <sub>BM</sub>	peak base current	single pulse; t <sub>p</sub> ≤ 1 ms	-	1	А
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1] -	370	mW
			[2] -	570	mW
			[3] -	530	mW
			[4] -	700	mW
			[5] -	450	mW
			[6] -	760	mW
			[7] -	700	mW
			[8] -	1450	mW
Per device					
P <sub>tot</sub>	total power dissipation	on $T_{amb} \le 25 \ ^{\circ}C$	[1] -	510	mW
			[2] -	780	mW
			[3] -	730	mW
			[4] -	960	mW
			[5] -	620	mW
			[6] -	1040	mW
			[7] -	960	mW
		[8] -	2000	mW	
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature			55 150	°C
T <sub>stg</sub>	storage temperature		-(	65 150	°C

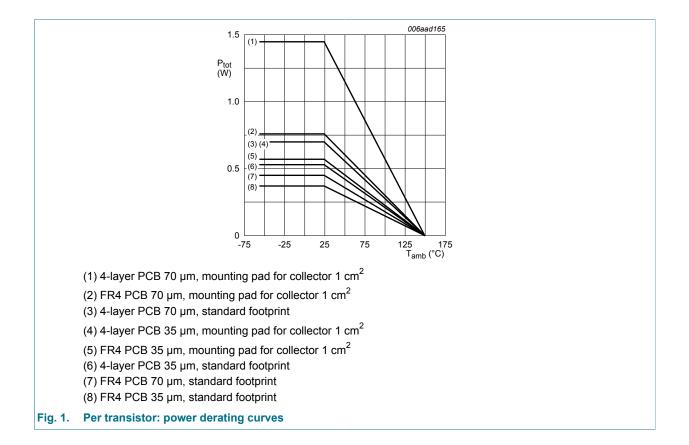
Device mounted on an FR4 PCB, single-sided 35 µm copper strip line, tin-plated and standard footprint.
 Device mounted on an FR4 PCB, single-sided 35 µm copper strip line, tin-plated, mounting pad for

- collector 1 cm<sup>2</sup>.
- [3] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated and standard footprint.
- <sup>[4]</sup> Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [5] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated and standard footprint.
- [6] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [7] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated and standard footprint.
- <sup>[8]</sup> Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

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## 9. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per transis	tor		l.				
R <sub>th(j-a)</sub>	thermal resistance	in free air	[1]	-	-	338	K/W
from junction to ambient		[2]	-	-	219	K/W	
		[3]	-	-	236	K/W	
		[4] [5] [6] [7] [8]	[4]	-	-	179	K/W
			[5]	-	-	278	K/W
			[6]	-	-	164	K/W
			[7]	-	-	179	K/W
			[8]	-	-	86	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point			-	-	30	K/W

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4/17

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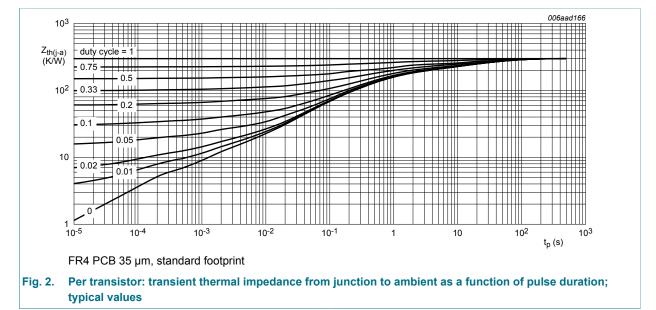
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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Per device							
R <sub>th(j-a)</sub>	thermal resistance	in free air	[1]	-	-	245	K/W
from junction to ambient		[2]	-	-	160	K/W	
	-	[3]	-	-	171	K/W	
		[4]	-	-	130	K/W	
			[5]	-	-	202	K/W
			[6]	-	-	120	K/W
		[7]	-	-	130	K/W	
			[8]	-	-	63	K/W

Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated and standard footprint.
 Device mounted on an FR4 PCB, single-sided 35 μm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

[3] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated and standard footprint.

- [4] Device mounted on 4-layer PCB 35 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [5] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated and standard footprint.
- [6] Device mounted on an FR4 PCB, single-sided 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [7] Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated and standard footprint.
- <sup>[8]</sup> Device mounted on 4-layer PCB 70 µm copper strip line, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

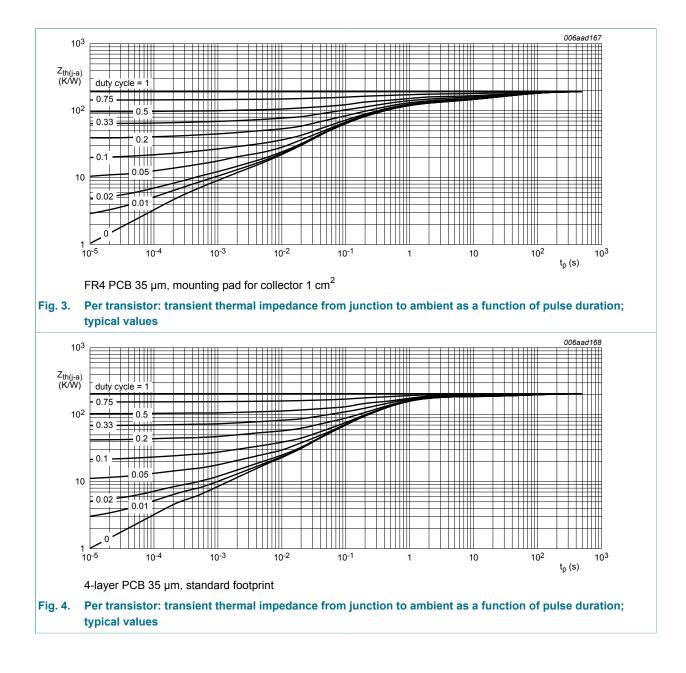


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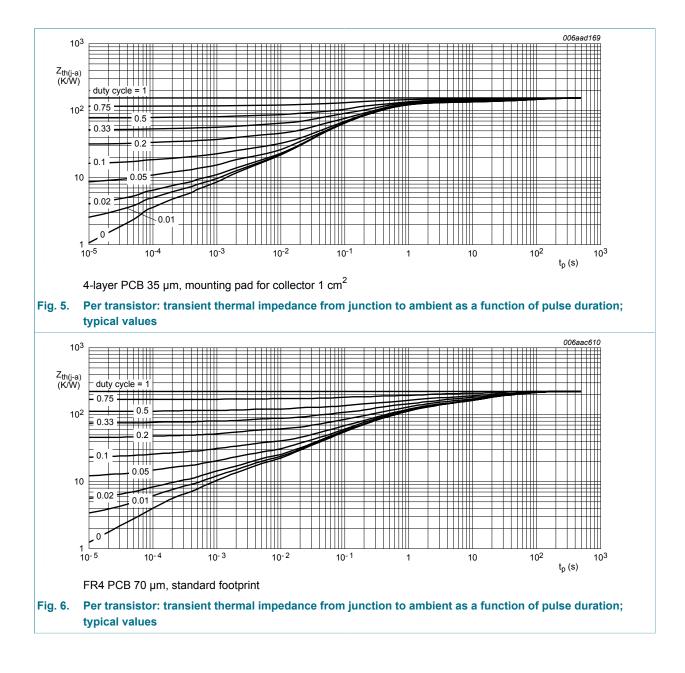
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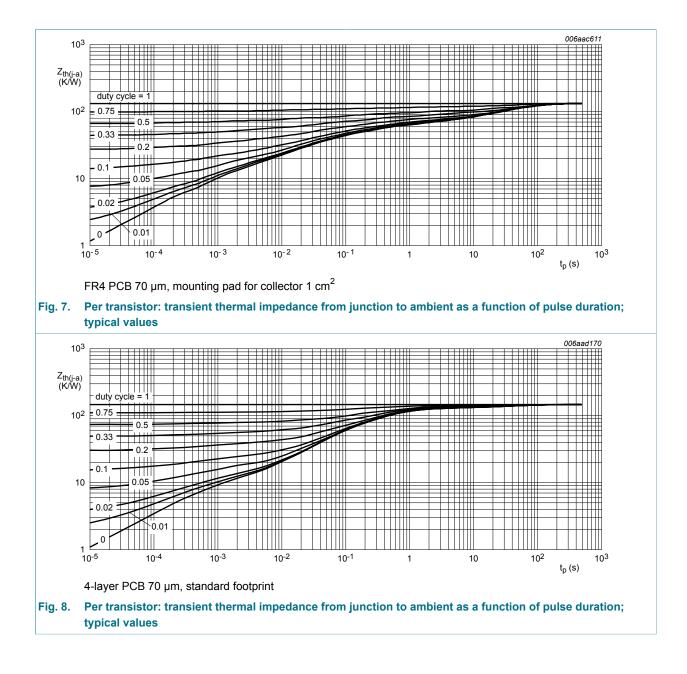
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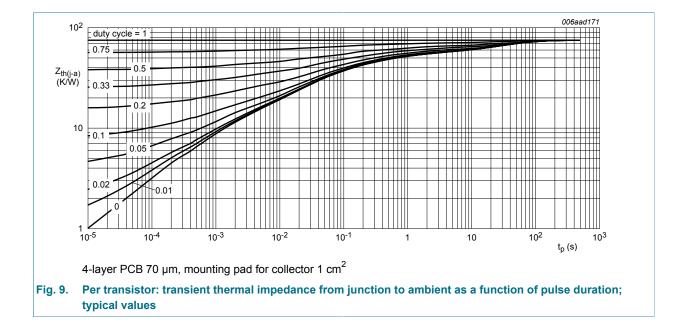
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## **10. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per transis	tor	· · · ·				
I <sub>CBO</sub>	collector-base cut-off	V <sub>CB</sub> = 48 V; I <sub>E</sub> = 0 A; T <sub>amb</sub> = 25 °C	-	-	100	nA
	current	V <sub>CB</sub> = 48 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C	-	-	50	μA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB}$ = 5 V; I <sub>C</sub> = 0 A; T <sub>amb</sub> = 25 °C	-	-	100	nA
h <sub>FE</sub> DC current gain	$\label{eq:VCE} \begin{array}{l} V_{CE} = 2 \; V; \; I_{C} = 100 \; \text{mA}; \; \text{pulsed}; \\ t_{p} \leq 300 \; \mu \text{s}; \; \delta \leq 0.02 \; ; \; T_{amb} = 25 \; ^{\circ} \text{C} \end{array}$	290	430	-		
		$\label{eq:VCE} \begin{array}{l} V_{CE} = 2 \; V; \; I_{C} = 500 \; \text{mA}; \; pulsed; \\ t_{p} \leq 300 \; \mu s; \; \delta \leq 0.02 \; ; \; T_{amb} = 25 \; ^{\circ}C \end{array}$	210	310	-	
		$V_{CE}$ = 2 V; I <sub>C</sub> = 1 A; pulsed; t <sub>p</sub> ≤ 300 µs; $\delta$ ≤ 0.02 ; T <sub>amb</sub> = 25 °C	120	185	-	
		$V_{CE}$ = 2 V; I <sub>C</sub> = 2 A; pulsed; t <sub>p</sub> ≤ 300 µs; $\delta$ ≤ 0.02 ; T <sub>amb</sub> = 25 °C	50	85	-	
V <sub>CEsat</sub>	collector-emitter	$I_{C}$ = 500 mA; $I_{B}$ = 50 mA; $T_{amb}$ = 25 °C	-	70	90	mV
	saturation voltage	$\begin{split} I_{C} &= 1 \text{ A};  I_{B} = 50 \text{ mA}; \text{ pulsed}; \\ t_{p} &\leq 300  \mu\text{s};  \delta \leq 0.02 \text{ ; }  T_{amb} = 25 ^{\circ}\text{C} \end{split}$	-	140	180	mV
		$I_C$ = 2 A; $I_B$ = 100 mA; pulsed; $t_p \le 300$ μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	270	350	mV
		$I_{C}$ = 2 A; $I_{B}$ = 200 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C	-	255	330	mV

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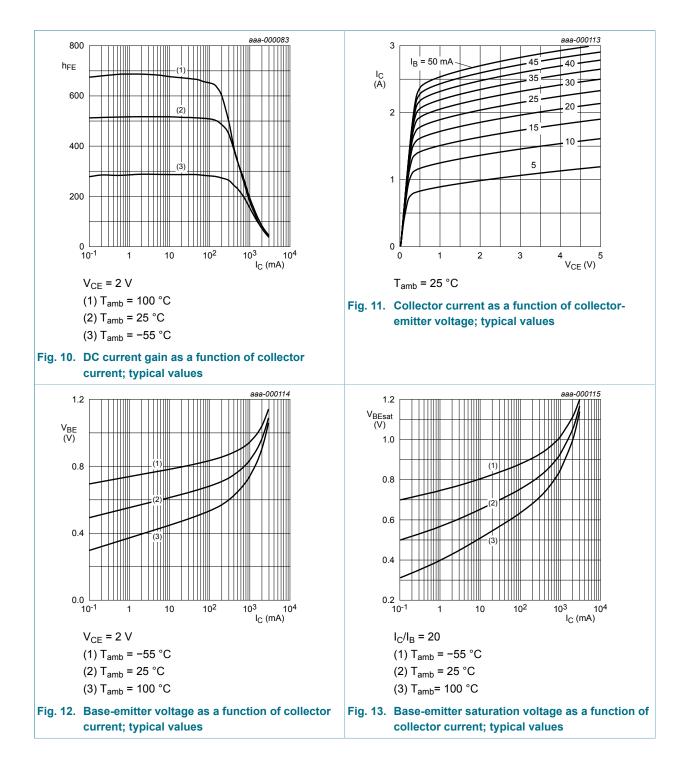
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C}$ = 1 A; $I_{B}$ = 100 mA; pulsed; $t_{p}$ ≤ 300 μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-	165	mΩ
V <sub>BEsat</sub>	base-emitter saturation	$I_{C}$ = 500 mA; $I_{B}$ = 50 mA; $T_{amb}$ = 25 °C	-	-	1	V
voltage	voltage	$I_{C}$ = 1 A; $I_{B}$ = 50 mA; pulsed; $t_{p}$ ≤ 300 μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-	1	V
		$I_{C}$ = 2 A; $I_{B}$ = 100 mA; pulsed; $t_{p}$ ≤ 300 μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-	1.1	V
		$I_{C}$ = 2 A; $I_{B}$ = 200 mA; pulsed; $t_{p}$ ≤ 300 μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-	1.2	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$\label{eq:Vce} \begin{array}{l} V_{CE} = 2 \; V; \; I_{C} = 0.5 \; A; \; pulsed; \\ t_{p} \leq 300 \; \mu s; \; \delta \leq 0.02 \; ; \; T_{amb} = 25 \; ^{\circ}C \end{array}$	-	-	0.9	V
t <sub>d</sub>	delay time	V <sub>CC</sub> = 12.5 V; I <sub>C</sub> = 1 A; I <sub>Bon</sub> = 50 mA;	-	10	-	ns
t <sub>r</sub>	rise time	I <sub>Boff</sub> = -50 mA; T <sub>amb</sub> = 25 °C	-	140	-	ns
t <sub>on</sub>	turn-on time		 -	150	-	ns
t <sub>s</sub>	storage time		-	445	-	ns
t <sub>f</sub>	fall time		-	180	-	ns
t <sub>off</sub>	turn-off time		-	625	-	ns
f <sub>T</sub>	transition frequency	$V_{CE}$ = 10 V; I <sub>C</sub> = 50 mA; f = 100 MHz; T <sub>amb</sub> = 25 °C	70	140	-	MHz
C <sub>c</sub>	collector capacitance	V <sub>CB</sub> = 10 V; I <sub>E</sub> = 0 A; i <sub>e</sub> = 0 A; f = 1 MHz; T <sub>amb</sub> = 25 °C	-	6.5	9	pF

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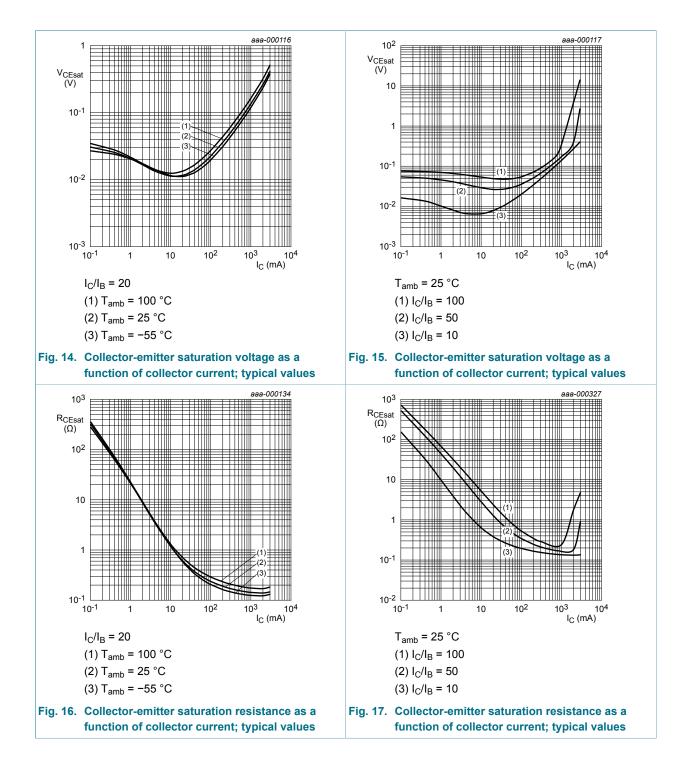
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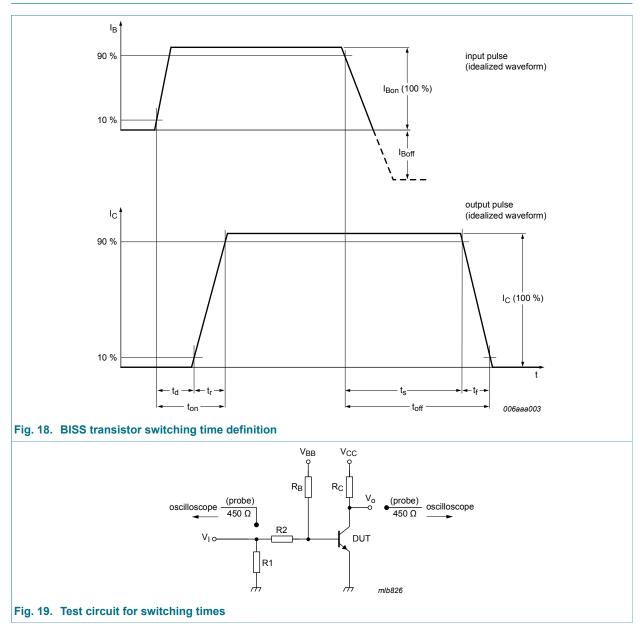
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12/17

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# **11. Test information**



## **11.1 Quality information**

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

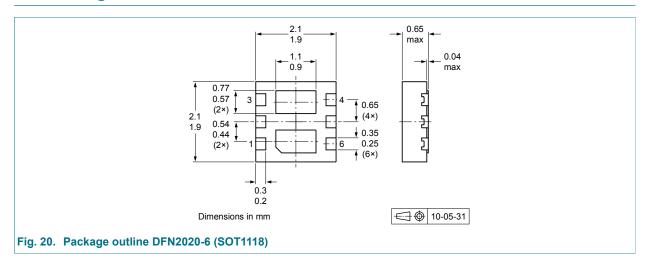
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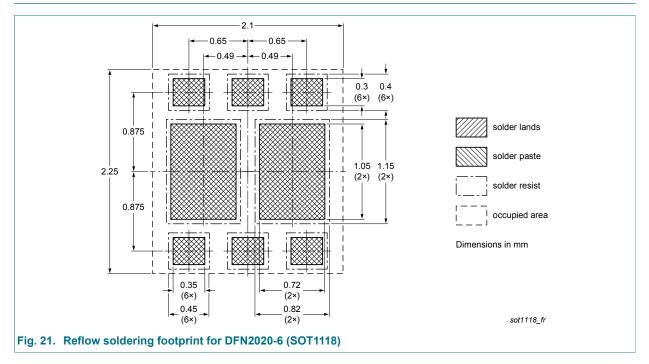
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# 12. Package outline



## 13. Soldering



## 14. Revision history

Table 8. Revision his	story			
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4260PAN v.1	20121212	Product data sheet	-	-
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Product data sheet 12 December 2012				14 / 17

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## 15. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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## 16. Contents

1	General description1
2	Features and benefits1
3	Applications1
4	Quick reference data1
5	Pinning information2
6	Ordering information2
7	Marking2
8	Limiting values2
9	Thermal characteristics4
10	Characteristics9
11	Test information13
11.1	Quality information
12	Package outline 14
13	Soldering 14
14	Revision history14
15	Legal information15
15.1	Data sheet status 15
15.2	Definitions15
15.3	Disclaimers15
15.4	Trademarks 16

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